



SSC8021GS8

P-Channel Enhancement Mode MOSFET with ESD Protection

➤ Features

| VDS | VGS | RDS(on) Typ. | ID | ESD |
|------|------|--------------|-----|-----|
| -20V | ±12V | 0.6R@-4V5 | -1A | 2kV |
| | | 0.8R@-2V5 | | |

➤ Description

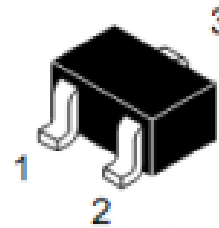
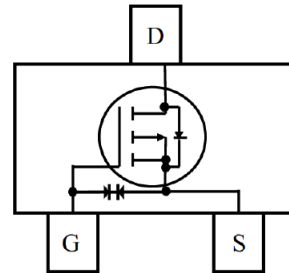
This device is produced with high cell density DMOS trench technology, which is especially used to minimize on-state resistance. This device particularly suits low voltage applications such as portable equipment, power management and other battery powered circuits, and low in-line power dissipation are needed in a very small outline surface mount package. The product does not contain Rohs substances such as lead and halogen.

➤ Applications

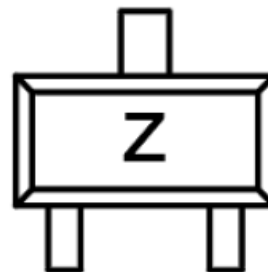
- Load Switch
- Portable Devices
- DCDC conversion

➤ Pin configuration

Top view



SOT523



Marking

➤ Ordering Information

| Device | Package | Shipping |
|------------|---------|-----------|
| SSC8021GS8 | SOT523 | 3000/Reel |



➤ **Absolute Maximum Ratings**($T_A=25^{\circ}\text{C}$ unless otherwise noted)

| Symbol | Parameter | Ratings | Unit |
|-----------|---------------------------------------|------------|--------------------|
| V_{DSS} | Drain-to-Source Voltage | -20 | V |
| V_{GSS} | Gate-to-Source Voltage | ± 12 | V |
| I_D | Continuous Drain Current ^a | -1 | A |
| I_{DM} | Pulsed Drain Current ^b | -2.7 | A |
| P_D | Power Dissipation ^c | 0.36 | W |
| P_{DSM} | Power Dissipation ^a | 0.22 | W |
| T_J | Operation junction temperature | -55 to 150 | $^{\circ}\text{C}$ |
| T_{STG} | Storage temperature range | -55 to 150 | $^{\circ}\text{C}$ |

➤ **Thermal Resistance Ratings**($T_A=25^{\circ}\text{C}$ unless otherwise noted)

| Symbol | Parameter | Typical | Maximum | Unit |
|-----------------|--|---------|---------|-----------------------------|
| $R_{\theta JA}$ | Junction-to-Ambient Thermal Resistance | | 568 | $^{\circ}\text{C}/\text{W}$ |
| $R_{\theta JC}$ | Junction-to-Case Thermal Resistance | | 347 | |

Note:

- The value of $R_{\theta JA}$ is measured with the device mounted on 1 in² FR-4 board with 2oz.copper,in a still air environment with $T_A=25^{\circ}\text{C}$.The value in any given application depends on the user is specific board design. The current rating is based on the $t \leq 10\text{s}$ thermal resistance rating.
- Repetitive rating, pulse width limited by junction temperature.
- The power dissipation P_D is based on $T_{J(MAX)}=150^{\circ}\text{C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heat sinking is used.

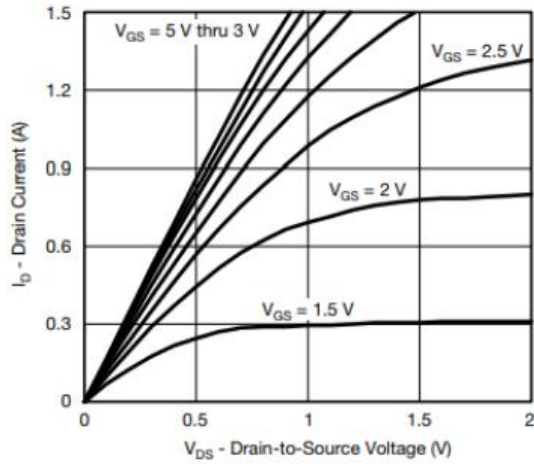


➤ **Electronics Characteristics**($T_A=25^{\circ}\text{C}$ unless otherwise noted)

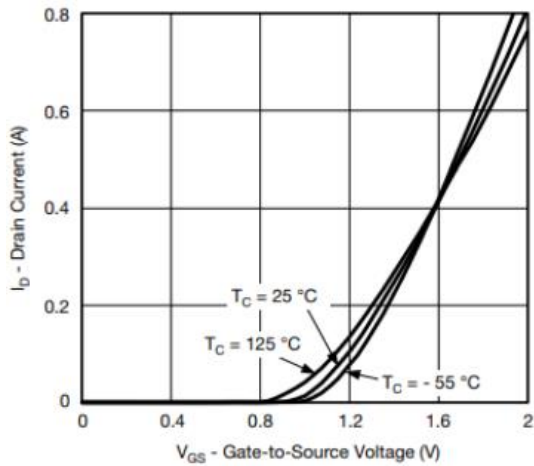
| Symbol | Parameter | Test Conditions | Min | Typ. | Max | Unit |
|---------------|------------------------------------|---|------|------|----------|---------|
| $V_{(BR)DSS}$ | Drain-Source Breakdown Voltage | $V_{GS}=0V, I_D=-250\mu A$ | -20 | | | V |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{DS}=V_{GS}, I_D=-250\mu A$ | -0.5 | -0.7 | -1 | V |
| $R_{DS(on)}$ | Drain-Source On- Resistance | $V_{GS}=-4.5V, I_D=-0.5A$ | | 600 | 750 | mR |
| | | $V_{GS}=-2.5V, I_D=-0.5A$ | | 800 | 1000 | |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS}=-16V, V_{GS}=0V$ | | | -1 | μA |
| I_{GSS} | Gate-Source leak current | $V_{GS}=\pm 12V, V_{DS}=0V$ | | | ± 10 | μA |
| G_{FS} | Transconductance | $V_{DS}=-5V, I_D=-0.45A$ | | 1.5 | | S |
| V_{SD} | Forward Voltage | $V_{GS}=0V, I_S=-0.15A$ | | | -1.2 | V |
| C_{iss} | Input Capacitance | $V_{DS}=10V, V_{GS}=0V,$ $F=200KHZ$ | | 105 | | pF |
| C_{oss} | Output Capacitance | | | 22 | | |
| C_{rss} | Reverse Transfer Capacitance | | | 18 | | |
| $T_{D(ON)}$ | Turn-on delay time | $V_{GS}=6V,$ $V_{GEN}=4.5V, R_L=6R,$ $R_G=6R, I_D=0.5A$ | | 54 | | ns |
| T_r | Rise time | | | 85 | | |
| $T_{D(OFF)}$ | Turn-off delay time | | | 890 | | |
| T_f | Fall time | | | 176 | | |



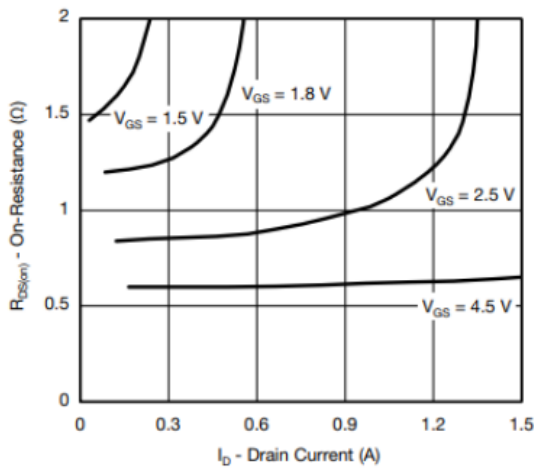
➤ **Typical Characteristics** ($T_A=25^\circ\text{C}$ unless otherwise noted)



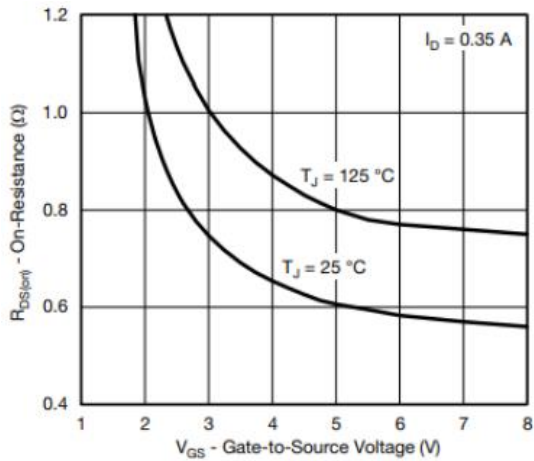
Output Characteristics



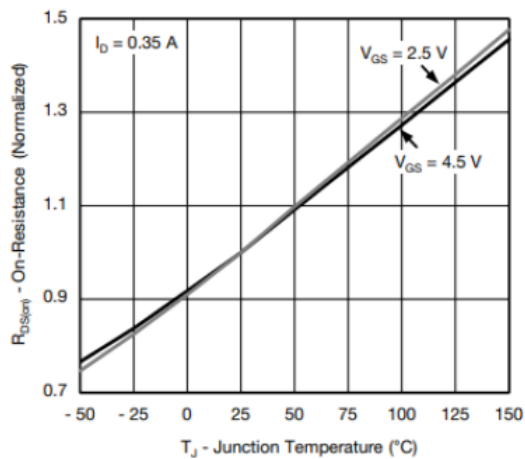
Transfer Characteristics



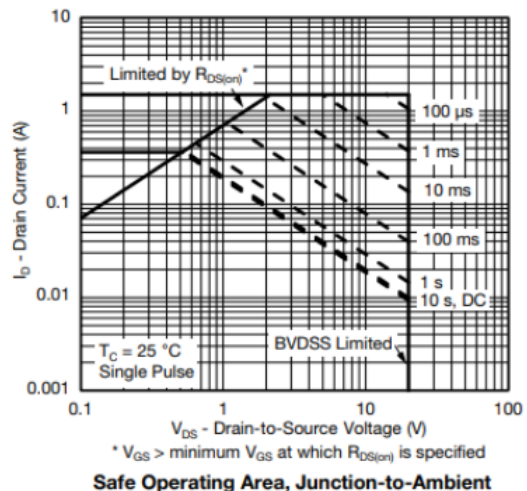
On-Resistance vs. Drain Current



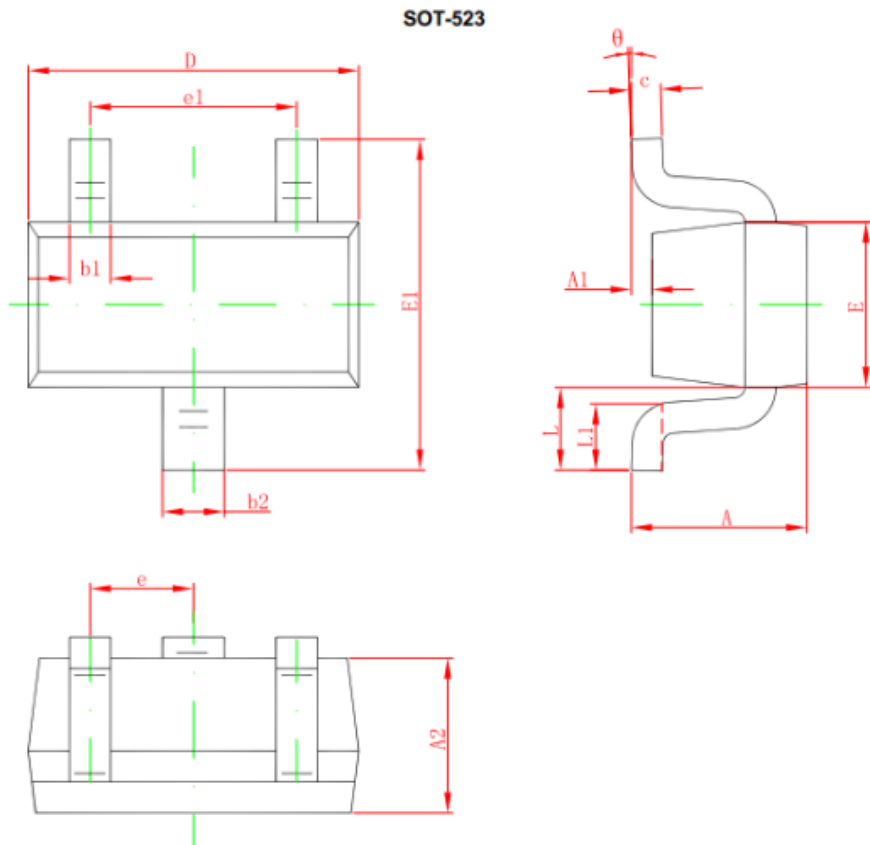
On-Resistance vs. Gate-to-Source Voltage



On-Resistance vs. Junction Temperature



Safe Operating Area, Junction-to-Ambient

➤ Package Information


| Symbol | Dimension in Millimeters | |
|--------|--------------------------|-------|
| | Min. | Max. |
| A | 0.700 | 0.900 |
| A1 | 0.000 | 0.100 |
| A2 | 0.700 | 0.800 |
| b1 | 0.150 | 0.250 |
| b2 | 0.250 | 0.350 |
| c | 0.100 | 0.200 |
| D | 1.500 | 1.700 |
| E | 0.700 | 0.900 |
| E1 | 1.450 | 1.750 |
| e | 0.500 Typ. | |
| e1 | 0.900 | 1.100 |
| L | 0.400 Ref. | |
| L1 | 0.260 | 0.460 |
| θ | 0° | 8° |



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